Search Notes

Application/Control No.	Applicant(s)/Patent u Reexamination	nder
10/849,956	NAKANO ET AL.	
Examiner	Art Unit	
Chuc D. Tran	2821	

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Class	Subclass	Date	Examiner
382	124	3/6/2006	тс
382	115	3/6/2006	тс
340	5.53	3/6/2006	TC

INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
382	124	3/6/2006	TC
382	115	3/6/2006	TC
340	5.53	3/6/2006	TC
Interferend Hist		3/6/2006	тс

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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